



# **Dual P-Channel 20-V (D-S) MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ.)	
- 20	0.058 at V <sub>GS</sub> = - 4.5 V	- 6 <sup>a</sup>	5.5 nC	
	0.100 at V <sub>GS</sub> = - 2.5 V	- 6 <sup>a</sup>	5.5 110	

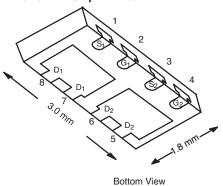
#### **FEATURES**

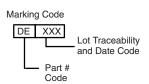
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET<sup>®</sup> Power MOSFET
- New Thermally Enhanced PowerPAK<sup>®</sup> ChipFET<sup>®</sup> Package
  - Small Footprint Area
  - Low On-Resistance
  - Thin 0.8 mm Profile



ROHS COMPLIANT HALOGEN FREE

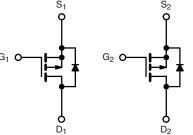
#### **PowerPAK ChipFET Dual**





#### **APPLICATIONS**

 Load Switch, PA Switch, and Charger Switch for Portable Devices
 S<sub>2</sub>



P-Channel MOSFET

P-Channel MOSFET

Ordering Information: Si5947DU-T1-GE3 (	(Lead (Pb)-free and Halogen-free)

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		$V_{DS}$	- 20	V	
Gate-Source Voltage		$V_{GS}$	± 12		
	T <sub>C</sub> = 25 °C		- 6 <sup>a</sup>		
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	$T_C = 70  ^{\circ}C$	I <sub>D</sub>	- 6 <sup>a</sup>	A	
Continuodo Brain Carrent (15 = 100 °C)	T <sub>A</sub> = 25 °C	טי	- 5 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		- 4 <sup>b, c</sup>		
Pulsed Drain Current		I <sub>DM</sub>	- 20		
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	I <sub>S</sub>	- 6 <sup>a</sup>		
Continuous Gource-Drain Diode Guirent	T <sub>A</sub> = 25 °C	'5	- 1.9 <sup>b, c</sup>		
	T <sub>C</sub> = 25 °C		10.4		
Maximum Power Discipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	6.7	W	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	' Б	2.3 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		1.5 <sup>b, c</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) <sup>d, e</sup>		·	260		

THERMAL RESISTANCE RATINGS						
Parameter	Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 5 s	R <sub>thJA</sub>	43	55	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	$R_{thJC}$	9.5	12		

#### Notes:

- a. Package limited.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 5 s
- d. See Solder Profile (<a href="www.vishay.com/ppg?73257">www.vishay.com/ppg?73257</a>). The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under Steady State conditions is 105 °C/W.

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Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V, } I_{D} = -250 \mu\text{A}$	- 20			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$			- 19		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = - 250 μA		2.6			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 0.6		- 1.5	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$			± 100	nA	
· ·		V <sub>DS</sub> = - 20 V, V <sub>GS</sub> = 0 V			- 1	μА	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = - 20 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			- 10		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	- 20			Α	
	, ,	V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 3.6 A		0.048	0.058	Ω	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 2.5 V, I <sub>D</sub> = - 1 A		0.081	0.100		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 10 V, I <sub>D</sub> = - 3.6 A		10		S	
Dynamic <sup>b</sup>	- 19			1	L	1	
Input Capacitance	C <sub>iss</sub>			480		pF	
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = - 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz		125			
Reverse Transfer Capacitance	C <sub>rss</sub>	30 40		90			
Total Gate Charge	Qg	V <sub>DS</sub> = - 10 V, V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 5 A		11	17	nC	
		20 4 00 4 2		5.5	8.5		
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -5 \text{ A}$		1.2			
Gate-Drain Charge	Q <sub>gd</sub>			1.8			
Gate Resistance	R <sub>g</sub>	f = 1 MHz		9		Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			11	20		
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 10 V, $R_L$ = 2.5 $\Omega$		42	65	- ns	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong -4 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$		33	50		
Fall Time	t <sub>f</sub>			50	75		
Turn-On Delay Time	t <sub>d(on)</sub>			5	10		
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 10 V, $R_L$ = 2.5 $\Omega$		15	25		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong$ - 4 A, $V_{GEN}$ = - 10 V, $R_g$ = 1 $\Omega$		25	40		
Fall Time	t <sub>f</sub>			10	20		
<b>Drain-Source Body Diode Characteristic</b>	cs				L		
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 6		
Pulse Diode Forward Current	I <sub>SM</sub>				- 20	A	
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = - 4 A, V <sub>GS</sub> = 0 V		- 0.9	- 1.2	٧	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			25	50	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$I_F = -4 \text{ A, dI/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 \text{ °C}$		10	20	nC	
Reverse Recovery Fall Time	t <sub>a</sub>			9		ns	
Reverse Recovery Rise Time	t <sub>b</sub>			16			

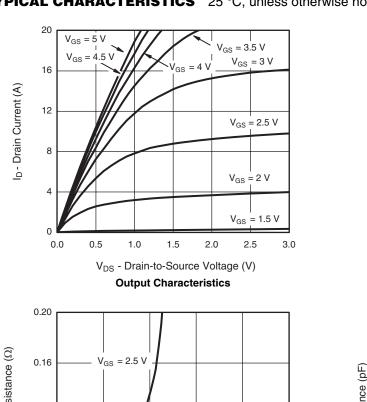
#### Notes:

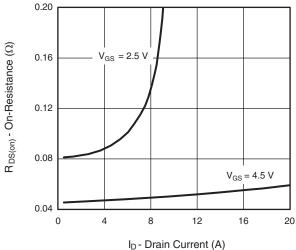
- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

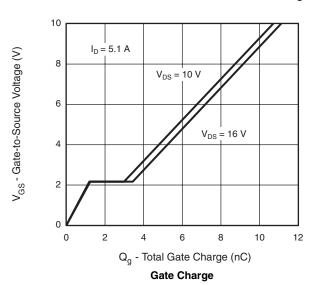


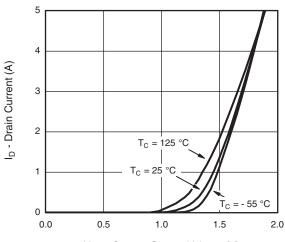
### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



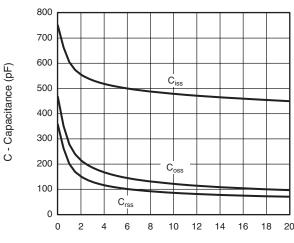


#### On-Resistance vs. Drain Current and Gate Voltage

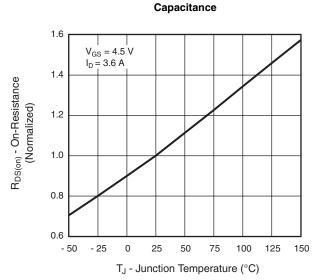




V<sub>GS</sub> - Gate-to-Source Voltage (V) **Transfer Characteristics** 



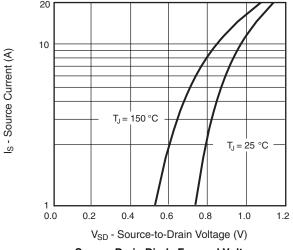
V<sub>DS</sub> - Drain-to-Source Voltage (V)



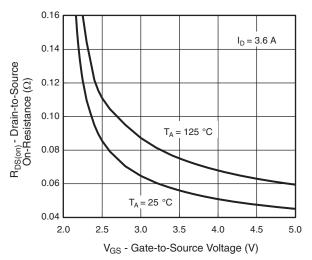
On-Resistance vs. Junction Temperature

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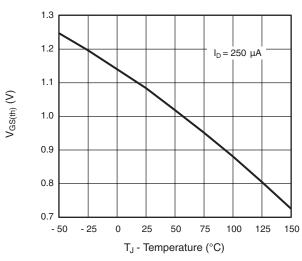
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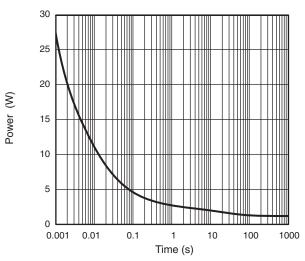




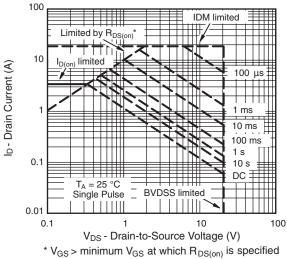
On-Resistance vs. Gate-to-Source Voltage



**Threshold Voltage** 



Single Pulse Power, Junction-to-Ambient



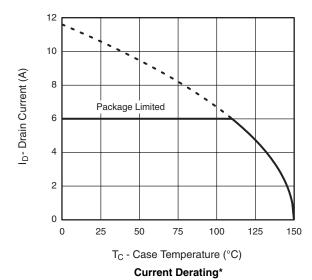
Safe Operating Area, Junction-to-Case

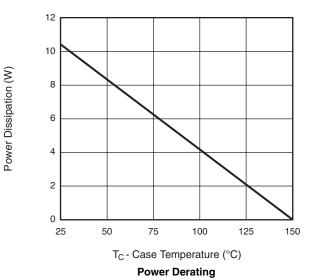






### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



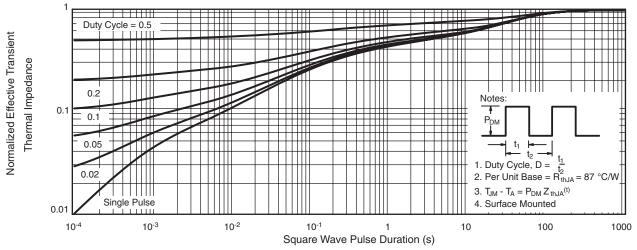


<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

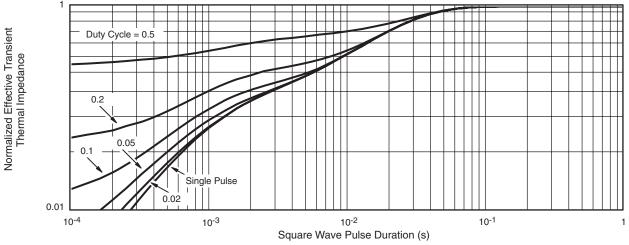
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### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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